Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/682,593	HAN ET AL.	
Examiner	**Art Unit**	
Tam M. Nguyen	1764	

SEARCHED			
Class	Subclass	Date	Examiner
208	213 216R 217 254H	5/11/2006	TN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	5/11/2006	TN
Inventors searched	5/11/2006	TN